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November 2013

FQD19N10

N-Channel QFET $^{\rm @}$ MOSFET 100 V, 15.6 A, 100 m Ω

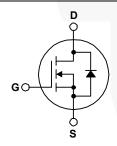
Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 15.6 A, 100 V, $R_{DS(on)}$ = 100 m Ω (Max.) @ V_{GS} = 10 V, I_D = 7.8 A
- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 32 pF)
- · 100% Avalanche Tested





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQD19N10TM	Unit	
V_{DSS}	Drain-Source V	oltage		100	V
I _D	Drain Current	- Continuous (T _C = 25°	C)	15.6	А
	- Continuous (T _C = 100°C)		9.8	Α	
I _{DM}	Drain Current	- Pulsed	(Note 1)	62.4	Α
V _{GSS}	Gate-Source Vo	oltage		± 25	V
E _{AS}	Single Pulsed A	e Pulsed Avalanche Energy		220	mJ
I _{AR}	Avalanche Current		(Note 1)	15.6	Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	6.0	V/ns
P_{D}	Power Dissipation (T _A = 25°C) *			2.5	W
Power Dissipation (T _C = 25°C)				50	W
	- Derate above 25°C			0.4	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C
T _L	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C

Thermal Characteristics

Symbol	Parameter	FQD19N10TM	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	2.5	
В	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	110	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (*1 in ² Pad of 2-oz Copper), Max.	50	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQD19N10TM	FQD19N10	D-PAK	Tape and Reel	330 mm	16 mm	2500 units

Electrical Characteristics T_C = 25°C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		0.1		V/°C
I _{DSS}	Zara Cata Valtaga Drain Current	V _{DS} = 100 V, V _{GS} = 0 V			1	μА
	Zero Gate Voltage Drain Current	$V_{DS} = 80 \text{ V}, T_C = 125^{\circ}\text{C}$			10	μА
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 7.8 A		0.078	0.1	Ω
9 _{FS}	Forward Transconductance	rward Transconductance $V_{DS} = 40 \text{ V}, I_D = 7.8 \text{ A}$		11		S
Dynami	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		600	780	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		165	215	pF
C _{rss}	Reverse Transfer Capacitance			32	40	pF
Switchi	ng Characteristics					
t _{d(on)}	Turn-On Delay Time	V = 50 V L = 10 A		7.5	25	ns
t _r	Turn-On Rise Time	$V_{DD} = 50 \text{ V, } I_{D} = 19 \text{ A,}$ $R_{G} = 25 \Omega$		150	310	ns
t _{d(off)}	Turn-Off Delay Time	1(G - 20 sz		20	50	ns
t _f	Turn-Off Fall Time	(Note 4)		65	140	ns
Qg	Total Gate Charge	V _{DS} = 80 V, I _D = 19 A,		19	25	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		3.9		nC
Q _{gd}	Gate-Drain Charge	(Note 4)	/	9.0		nC
Drain-S	ource Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				15.6	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current			62.4	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 15.6 A			1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 19 A,		78		ns
Q _{rr}	Reverse Recovery Charge	dI _F / dt = 100 A/μs		200	//	nC

- **Notes:** 1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 1.35 mH, I_{AS} = 15.6 A, V_{DD} = 25 V, R_G = 25 Ω , starting T_J = 25°C. 3. $I_{SD} \le 19$ A, di/dt ≤ 300 A/ μ s, $V_{DD} \le BV_{DSS}$, starting T_J = 25°C. 4. Essentially independent of operating temperature.

Typical Characteristics

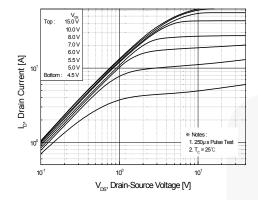


Figure 1. On-Region Characteristics

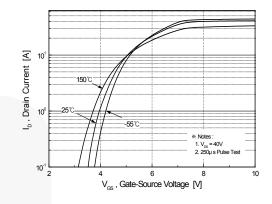


Figure 2. Transfer Characteristics

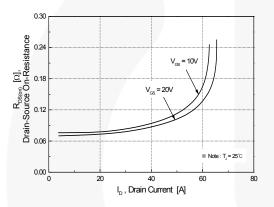


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

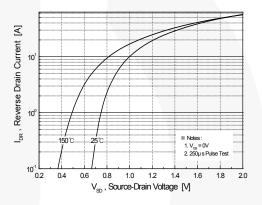


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

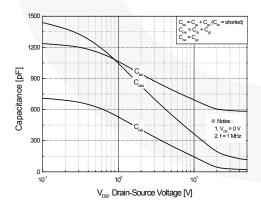


Figure 5. Capacitance Characteristics

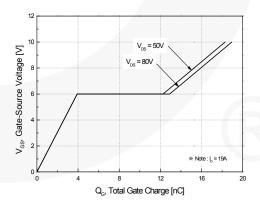
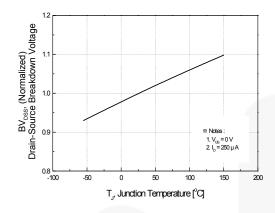


Figure 6. Gate Charge Characteristics

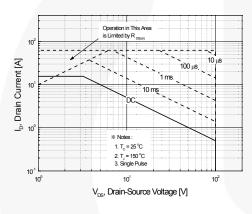
Typical Characteristics (Continued)



30 (Position Temperature [°C]

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



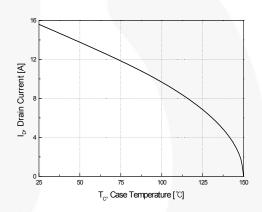


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

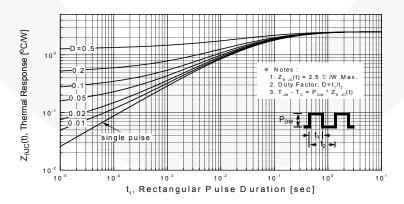


Figure 11. Transient Thermal Response Curve

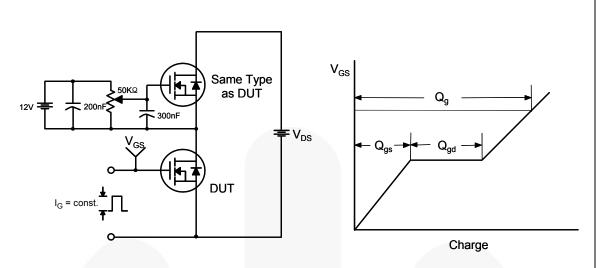


Figure 12. Gate Charge Test Circuit & Waveform

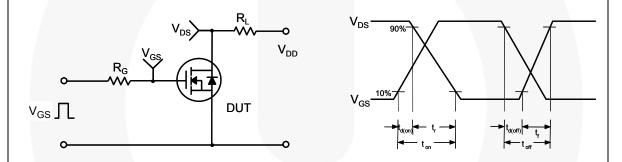


Figure 13. Resistive Switching Test Circuit & Waveforms

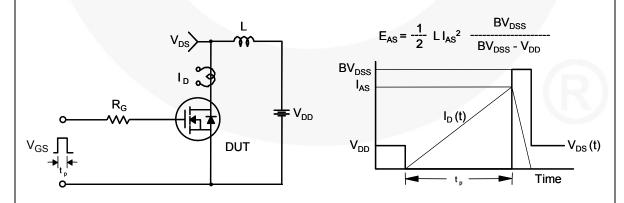
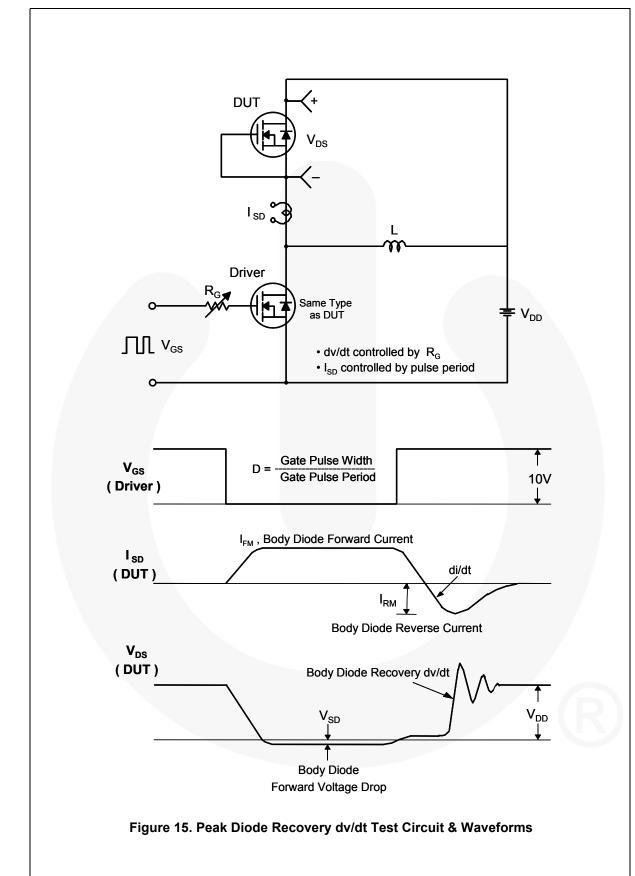


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

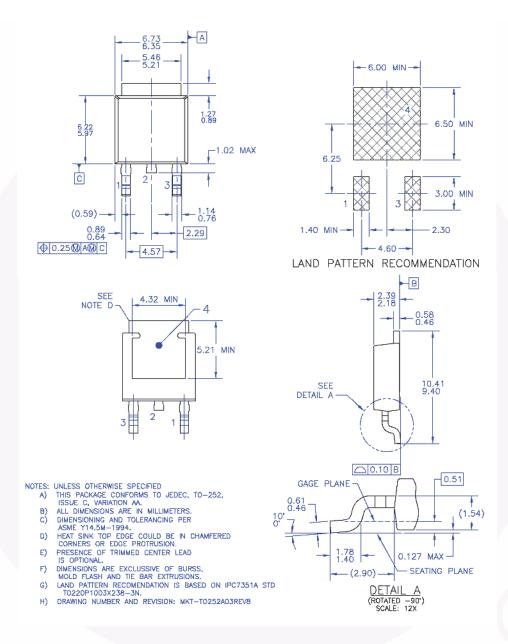


Figure 16. TO252 (D-PAK), Molded, 3-Lead, Option AA&AB

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